

# Search Notes



Application/Control No.

10/671,016

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

DUPUIS ET AL.

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	311	4/8/05	H. C.
"	310	"	"
"	251	"	"
"	307	"	"
"	98	"	"
"	150	4/4/05	"
257	500	"	"
"	509	"	"
"	548	4/12/05	"
"	351	"	"

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Tal search (East)	4/12/05	H. C.
NPL (IEEE)	"	"